


<b>Search Notes</b>  	<b>Application/Control No.</b>  10581304	<b>Applicant(s)/Patent Under Reexamination</b>  TONOUCHI ET AL.
	<b>Examiner</b>  RONALD T NIEBAUER	<b>Art Unit</b>  1654

SEARCHED			
Class	Subclass	Date	Examiner
NONE		8/25/09	rtn
NONE		3/24/10	rtn

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search in PALM - see enclosed	8/25/09	rtn
EAST search (uspgpub,uspat,usocr,fprs,epo,jpo,derwent) - see enclosed	8/25/09	rtn
STN search (reg,caplus,biosis,embase,medline,scisearch,prompt) - see enclosed	8/25/09	rtn
STIC sequence search - see SCORE content	8/25/09	rtn
review ISR - see edan	8/25/09	rtn
STN search (reg,hcaplus) - see enclosed	9/10/09	rtn
inventor search in PALM - see enclosed	3/24/10	rtn
EAST search (uspgpub,uspat,usocr,fprs,epo,jpo,derwent) - see enclosed	3/24/10	rtn
STN search (reg,caplus,biosis,embase,medline,scisearch,prompt) - see enclosed	3/24/10	rtn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/RONALD T NIEBAUER/ Examiner.Art Unit 1654	
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